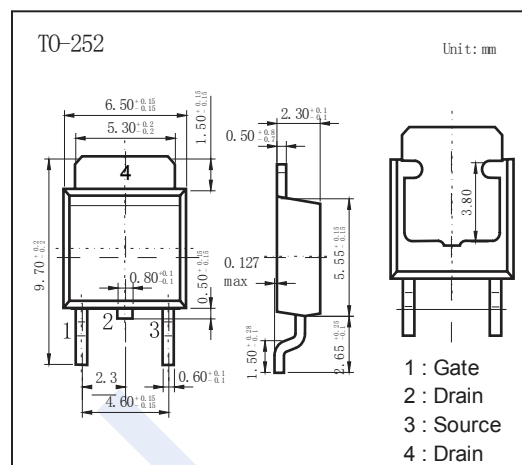
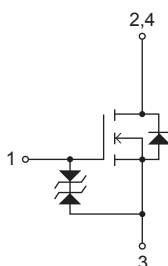


N-Channel Enhancement MOSFET

NDT35N06

■ Features

- $V_{DS} (V) = 60V$
- $I_D = 35 A$
- $R_{DS(ON)} < 23m\Omega$ ($V_{GS} = 10V$)
- $R_{DS(ON)} < 33m\Omega$ ($V_{GS} = 4.5V$)
- $R_{DS(ON)} < 37m\Omega$ ($V_{GS} = 4V$)

■ Absolute Maximum Ratings $T_a = 25^\circ C$

Parameter	Symbol	Rating	Unit
Drain-Source Voltage	V_{DS}	60	V
Gate-Source Voltage	V_{GS}	± 20	
Continuous Drain Current	I_D	35	A
Pulsed Drain Current (Note.1)	I_{DP}	105	
Avalanche Current (Note.2)	I_{AV}	18	
Avalanche Energy (Single Pulse) (Note.3)	E_{AS}	19	mJ
Power Dissipation $T_c=25^\circ C$	P_D	40	W
Junction Temperature	T_J	150	$^\circ C$
Storage Temperature Range	T_{stg}	-55 to 150	

Note.1 : $PW \leq 10 \mu s$, duty cycle $\leq 1\%$

Note.2 : $L \leq 100 \mu H$, Single pulse

Note.3 : $V_{DD}=10V$, $L=100 \mu H$, $I_{AV}=18A$

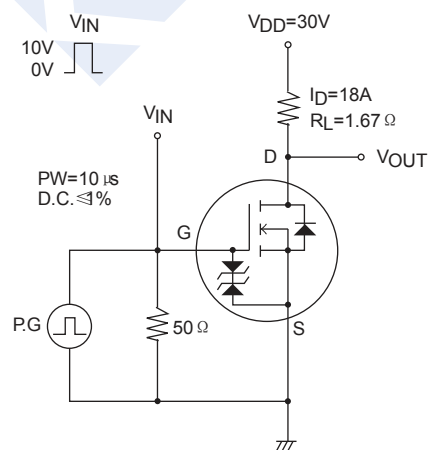
N-Channel Enhancement MOSFET

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■ Electrical Characteristics Ta = 25°C

Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
Drain-Source Breakdown Voltage	V_{DS}	$I_D=1\text{mA}$, $V_{GS}=0\text{V}$	60			V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS}=60\text{V}$, $V_{GS}=0\text{V}$			1	μA
Gate-Body Leakage Current	I_{GSS}	$V_{DS}=0\text{V}$, $V_{GS}=\pm 16\text{V}$			± 10	
Cutoff Voltage	$V_{GS(off)}$	$V_{DS}=10\text{V}$, $I_D=1\text{mA}$	1.2		2.6	V
Forward Transfer Admittance	$ Y_{fs} $	$V_{DS}=10\text{V}$, $I_D=18\text{A}$		35		S
Static Drain-Source On-Resistance	$R_{DS(on)1}$	$V_{GS}=10\text{V}$, $I_D=18\text{A}$		17	23	$\text{m}\Omega$
	$R_{DS(on)2}$	$V_{GS}=4.5\text{V}$, $I_D=9\text{A}$		23	33	
	$R_{DS(on)3}$	$V_{GS}=4.0\text{V}$, $I_D=5\text{A}$		25	37	
Input Capacitance	C_{iss}	$V_{GS}=0\text{V}$, $V_{DS}=20\text{V}$, $f=1\text{MHz}$		1820		pF
Output Capacitance	C_{oss}			150		
Reverse Transfer Capacitance	C_{rss}			100		
Total Gate Charge	Q_g	$V_{GS}=10\text{V}$, $V_{DS}=30\text{V}$, $I_D=35\text{A}$		34.5		nC
Gate Source Charge	Q_{gs}			6.5		
Gate Drain Charge	Q_{gd}			6.8		
Turn-On DelayTime	$t_{d(on)}$	See specified Test Circuit		16		ns
Turn-On Rise Time	t_r			110		
Turn-Off DelayTime	$t_{d(off)}$			125		
Turn-Off Fall Time	t_f			87		
Maximum Body-Diode Continuous Current	I_S				35	A
Diode Forward Voltage	V_{SD}	$I_S=35\text{A}$, $V_{GS}=0\text{V}$		0.96	1.2	V

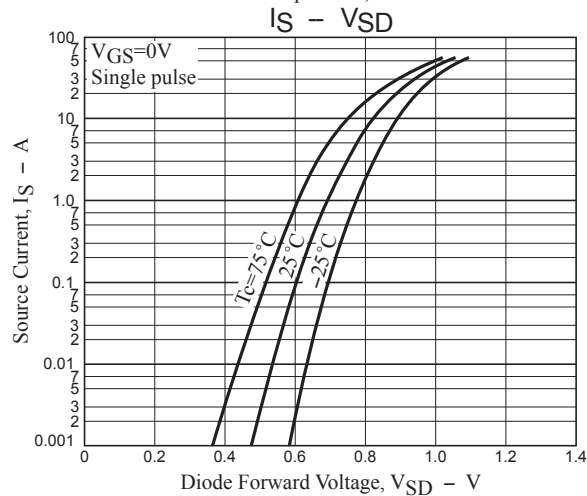
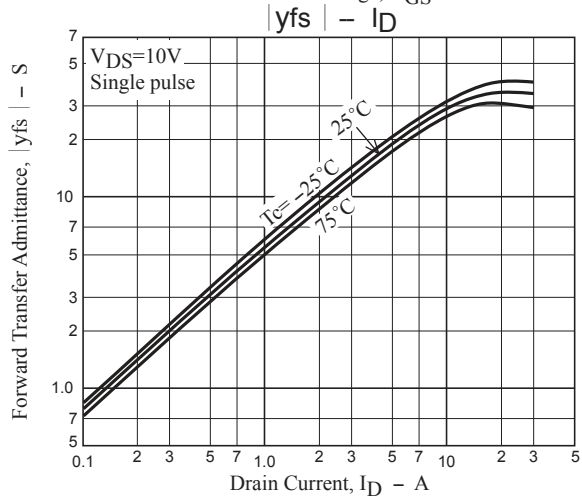
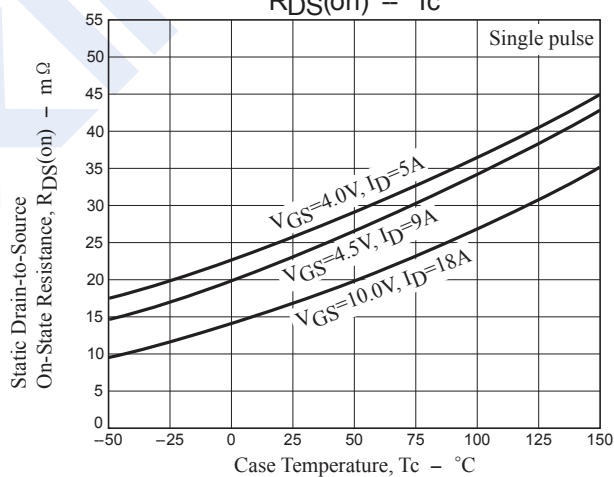
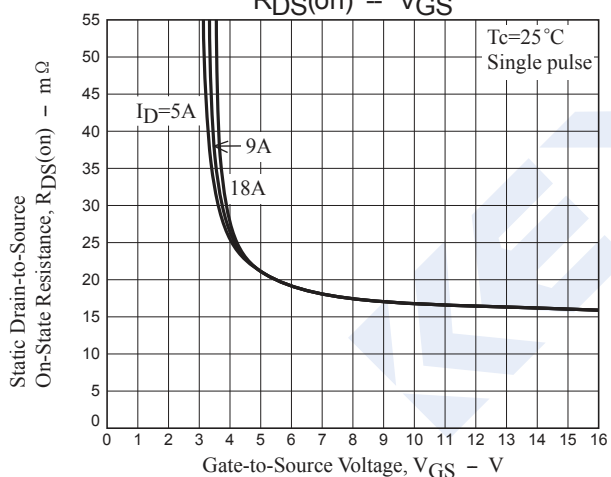
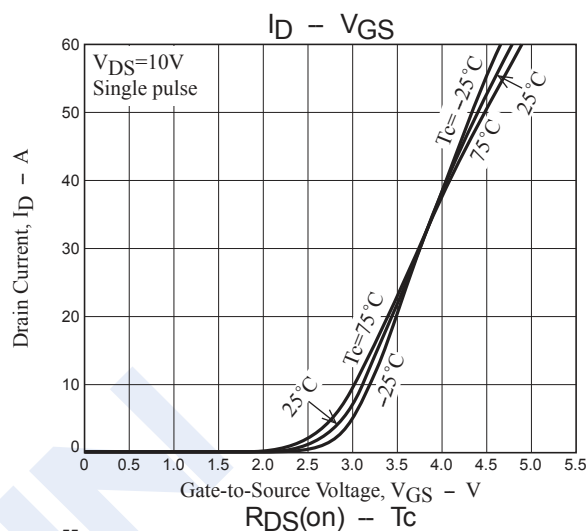
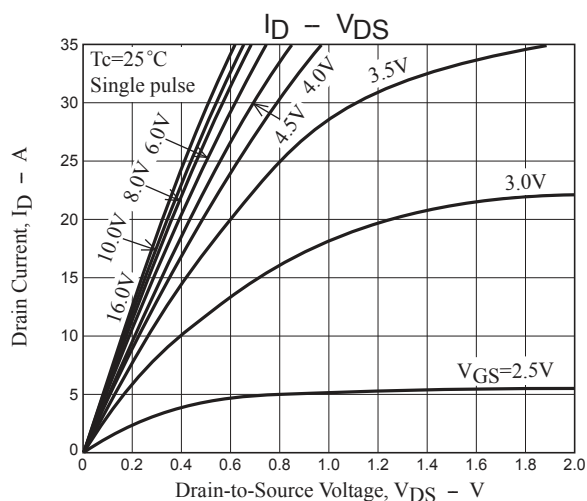
Switching Time Test Circuit:



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■ Typical Characteristics



N-Channel Enhancement MOSFET

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■ Typical Characteristics

